

Precision, 16 MHz CBFET Op Amp

AD845

16-Pin SOIC

NC a NO CONNECT

FEATURES

Replaces Hybrid Amplifiers in Many Applications

AC PERFORMANCE: Settles to 0.01% in 350 ns

100 V/μs Siew Rate

12.8 MHz min Unity-Gain Bandwidth
1.75 MHz Full-Power Bandwidth at 20 V p-p

DC PERFORMANCE:

0.25 mV max Input Offset Voltage 5 µV/℃ max Offset Voltage Drift 0.5 nA Input Bias Current

250 V/mV min Open-Loop Gain

4 μV p-p max Voltage Noise, 0.1 Hz to 10 Hz

94 dB min CMRR

Available in Plastic Mini-DIP, Hermetic Cerdip and SOIC Packages. Also Available in Tape and Reel in Accordance with EIA-481A Standard

PRODUCT DESCRIPTION

The AD845 is a fast, precise, N channel JFET input, monolithic operational amplifier. It is fabricated using Analog Devices' complementary bipolar (CB) process. Advanced laserwafer trimming technology enables the very low input offset voltage and offset voltage drift performance to be realized. This precision, when coupled with a slew rate of $100~V/\mu s$, a stable unity-gain bandwidth of 16~MHz, and a settling time of 350~ns 0.01%—while driving a parallel load of 100~pF and $500~\Omega$ —represents a combination of features unmatched by any FET input IC amplifier. The AD845 can easily be used to upgrade many existing designs which use BiFET or FET input hybrid amplifiers and, in some cases, those which use bipolar input op amps.

The AD845 is ideal for use in applications such as active filters, high speed integrators, photo diode preamps, sample-and-hold amplifiers, log amplifiers, and in buffering A/D and D/A converters. The 250 μV max input offset voltage makes offset nulling unnecessary in many applications. The common-mode rejection ratio of 110 dB over a ± 10 V input voltage range represents exceptional performance for a JFET input high speed op amp. This, together with a minimum open-loop gain of 250 V/mV ensures that 12-bit performance is achieved, even in unity-gain buffer circuits.

CONNECTION DIAGRAMS

Plastic Mini-DIP (N) Package

and Cerdip (Q) Package (R-16) Package AD845 8 NULL 16 NC 7 .v 15 NC 2 3 14 NULL INPUT 3 6 OUTPUT NULL TOP VIEW 13 +4 (Not to Scale 12 OUTPUT NC = NO CONNECT 6 11 NC AD845 7 10 NC TOP VIEW MC.

The AD845 conforms to the standard op amp pinout except that offset nulling is to V+. The AD845J and AD845K grade devices are available specified to operate over the commercial 0 to $+70^{\circ}$ C temperature range. AD845A and AD845B devices are specified for operation over the -40° C to $+85^{\circ}$ C industrial temperature range. The AD845S is specified to operate over the full military temperature range of -55° C to $+125^{\circ}$ C. Both the industrial and military versions are available in 8-pin cerdip packages. The commercial version is available in an 8-pin plastic mini-DIP and 16-pin SOIC; "J" and "S" grade chips are also available.

PRODUCT HIGHLIGHTS

- The high slew rate, fast settling time, and dc precision of the AD845 make it ideal for high speed applications requiring 12-bit accuracy.
- The performance of circuits using the LF400, HA2520/2/5, HA2620/2/5, 3550, OPA605, and LH0062 can be upgraded in most cases
- 3. The AD845 is unity-gain stable and internally compensated.
- 4. The AD845 is specified while driving 100 pF/500 Ω loads.

SPECIFICATIONS (@ +25°C and ±15 V dc, unless otherwise noted)

Model	Conditions	Min	AD845J/A Typ	Max	Min	AD845K/B Typ	Max	Min	AD845S Typ	Max	Units
INPUT OFFSET VOLTAGE ¹ Initial Offset Offset Drift	T _{min} -T _{max}		0.7	1.5 2.5 20		0.1 1.5	0.25 0.4 5.0		0.25	1.0 2.0 10	mV mV μV/°C
INPUT BIAS CURRENT ² Initial	$V_{CM} = 0 V$ $T_{min} - T_{max}$		0.75	2 45/75		0.5	1 18/38		0.75	2 500	nA nA
INPUT OFFSET CURRENT Initial	$V_{CM} = 0 V$ $T_{min} - T_{max}$		25	300 3/6.5		15	100 1.2/2.6		25	300 20	pA nA
INPUT CHARACTERISTICS Input Resistance Input Capacitance			10 ¹¹ 4.0			10 ¹¹ 4.0			10 ¹¹ 4.0		kΩ pF
INPUT VOLTAGE RANGE Differential Common Mode Common-Mode Rejection	$V_{CM} = \pm 10 \text{ V}$	±10 86	±20 + 10.5/-13		±10	±20 +10.5/-13		±10 86	±20 +10.5/-13 110	-	V V dB
INPUT VOLTAGE NOISE	0.1 to 10 Hz f = 10 Hz f = 100 Hz f = 100 Hz f = 1 kHz f = 10 kHz f = 100 kHz		4 80 60 25 18			4 80 60 25 18			4 80 60 25 18		$\mu V p-p$ nV/\sqrt{Hz} nV/\sqrt{Hz} nV/\sqrt{Hz} nV/\sqrt{Hz} nV/\sqrt{Hz}
INPUT CURRENT NOISE	f = 1 kHz		0.1			0.1			0.1		pA/√Hz
OPEN-LOOP GAIN	$\begin{aligned} V_{\rm O} &= \pm 10 \text{ V} \\ R_{\rm LOAD} &\geq 2 \text{ k}\Omega \\ R_{\rm LOAD} &\geq 500 \Omega \\ T_{\rm min} - T_{\rm max} \end{aligned}$	200 100 70	500 250		250 125 75	500 250		200 100 50	500 250		V/mV V/mV V/mV
OUTPUT CHARACTERISTICS Voltage Current Output Resistance	R _{LOAD} ≥500 Ω Short Circuit Open Loop	±12.5	50 5		±12.5	50 5		±12.5	50 5		V mA Ω
FREQUENCY RESPONSE Small Signal Full Power Bandwidth ³ Rise Time Overshoot Slew Rate Settling Time	Unity Gain $V_O = \pm 10 \text{ V}$ $R_{LOAD} = 500 \Omega$ 10 V Step	12.8	1.75 20 20 100		13.6	16 1.75 20 20 100		13.6	1.75 20 20 100		MHz MHz ns % V/µs
	$C_{LOAD} = 100 \text{ pF}$ $R_{LOAD} = 500 \Omega$ to 0.01% to 0.1%		350 250			350 250	500		350 250	500	ns ns ns ns
DIFFERENTIAL GAIN	f = 4.4 MHz		0.04			0.04			0.04		%
DIFFERENTIAL PHASE	f = 4.4 MHz		0.02			0.02			0.02		Degree
POWER SUPPLY Rated Performance Operating Range Rejection Ratio Quiescent Current	$V_{S} = \pm 5 \text{ to } \pm 15 \text{ V}$ $T_{min} \text{ to } T_{max}$	±4.75	±15 110 10	±18	±4.75	±15 113 10	±18	±4.75	±15	±18	V V dB mA

All min and max specifications are guaranteed. Specifications shown in boldface are tested on all production units at final electrical test. Results from these tests are used to calculate outgoing quality levels.

Specifications subject to change without notice.

¹Input offset voltage specifications are guaranteed after 5 minutes of operation at $T_A = +25$ °C.

²Bias current specifications are guaranteed maximum at either input after 5 minutes of operation at $T_A = +25^{\circ}$ C.

FPBW slew rate/ 2π V peak.

"S" grade T_{min} T_{max} are tested with automatic test equipment at $T_A = -55^{\circ}$ C and $T_A = +125^{\circ}$ C.

AD845

ARSOLUTE MAXIMUM RATINGS1

ADSOLUTE METALMICM KITTINGS
Supply Voltage
Internal Power Dissipation ²
Plastic Mini-DIP
Cerdip
16-Pin SOIC
Input Voltage $\dots \pm V_S$
Output Short-Circuit Duration Indefinite
Differential Input Voltage+V _S and -V _S
Storage Temperature Range
Q
N, R
Lead Temperature Range (Soldering 60 sec)+300°C

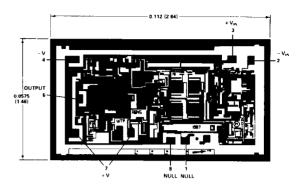
NOTES

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

 2 Mini-DIP package: $\theta_{JA}=100^\circ C/W;$ cerdip package: $\theta_{JA}=110^\circ C/W;$ SOIC package: $\theta_{JA}=100^\circ C/W.$

METALIZATION PHOTOGRAPH

Dimensions shown in inches and (mm). Contact factory for latest dimensions.



SUBSTRATE CONNECTED TO +Vs

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option*	
AD845JN	0°C to +70°C	8-Pin Plastic Mini-DIP	N-8	
AD845KN	0°C to +70°C	8-Pin Plastic Mini-DIP	N-8	
AD845JR	0°C to +70°C	16-Pin SOIC	R-16	
AD845AQ	-40°C to +85°C	8-Pin Cerdip	Q-8	
AD845BQ	-40°C to +85°C	8-Pin Cerdip	Q-8	
AD845SQ	-55°C to +125°C	8-Pin Cerdip	Q-8	
AD845SQ/883B	-55°C to +125°C	8-Pin Cerdip	Q-8	
5962-8964501PA	-55°C to +125°C	8-Pin Cerdip	Q-8	
AD845J Chips	0°C to +70°C	Die	_	
AD845S Chips	-55°C to +125°C	Die		
AD845JR-Reel	0°C to +70°C	Tape & Reel		

^{*}N = Plastic DIP; Q = Cerdip; R = Small Outline IC (SOIC). For outline information see Package Information section.